Application No.: 10/709,723

Docket No.: 22171-00016-US1

AMENDMENTS TO THE CLAIMS

This listing of claims will replace all prior versions and listings of claims in the application:

LISTING OF CLAIMS:

1. (Previously presented) A probe device for electrically testing an integrated circuit device, the probe device comprising:

an insulative body including at least one opening;

at least one supporter positioned inside the at least one opening of the insulative body, wherein the supporter comprises a helical spring with a spiral coil extending substantially in a same plane;

a probe positioned substantially at a center of the supporter, wherein the probe is arranged to electrically connect to a pad of the integrated circuit device during testing; and a conductive wire positioned in the insulative body and electrically connected to the supporter.

- 2. (Currently amended) The probe device of Claim 1, further comprising two supporters positioned substantially in parallel with each other inside the at least one opening of the insulative body.
 - 3. (Canceled).
 - 4. (Canceled)
 - 5. (Canceled).
 - 6. (Canceled).
 - 7. (Canceled).

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